

<b>Notice of References Cited</b>		Application/Control No. 10/707,713	Applicant(s)/Patent Under Reexamination EDELSTEIN ET AL.	
		Examiner Alexander O Williams	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0222330 A1	12-2003	Sun et al.	257/665
	B	US-4,331,970	05-1982	Yerman, Alexander J.	257/795
	C	US-5,287,003	02-1994	Van Andel et al.	257/792
	D	US-4,017,340	04-1977	Yerman, Alexander J.	148/33.3
	E	US-6,583,516 B2	06-2003	Hashimoto, Nobuaki	257/781
	F	US-6,368,899 B1	04-2002	Featherby et al.	438/127
	G	US-6,191,492 B1	02-2001	Yamazaki et al.	257/787
	H	US-2003/0122220 A1	07-2003	West et al.	257/620
	I	US-2002/0127776 A1	09-2002	Nakajo et al.	438/110
	J	US-5,287,003	02-1994	Van Andel et al.	257/792
	K	US-2003/0137062 A1	07-2003	Akram et al.	257/788
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.